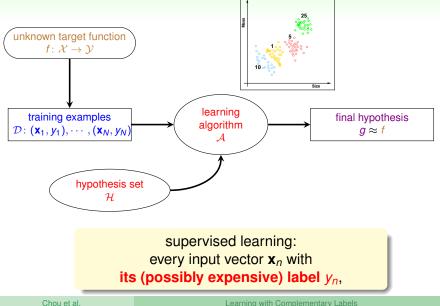
### Unbiased Risk Estimators Can Mislead: A Case Study of Learning with Complementary Labels

Yu-Ting Chou, Gang Niu, Hsuan-Tien Lin, Masashi Sugiyama

ICML 2020 work done during Chou's internship at RIKEN AIP, Japan; resulting M.S. thesis of Chou won the 2020 thesis award of TAAI

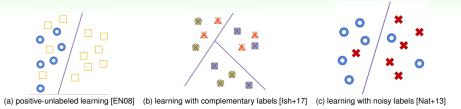
October 8, 2021, Al Forum, Taipei, Taiwan

### Supervised Learning (Slide Modified from My ML Foundations MOOC)



Introduction

## Weakly-supervised: Learning without True Labels y<sub>n</sub>



- positive-unlabeled: some of true  $y_n = +1$  revealed
- complementary: 'not label'  $\overline{y}_n$  instead of true  $y_n$
- noisy: noisy label y'<sub>n</sub> instead of true y<sub>n</sub>

# weakly-supervised: a realistic and hot research direction to reduce labeling burden

[EN08] Learning classifiers from only positive and unlabeled data, KDD'08.

[Ish+17] Learning from complementary labels, NeurIPS'17.

[Nat+13] Learning with noisy labels, NeurIPS'13.

Chou et al.

### Motivation

#### popular weakly-supervised models [DNS15; lsh+19; Pat+17]

- derive Unbiased Risk Estimators (URE) as new loss
- theoretically, nice properties (unbiased, consistent, etc.) [Ish+17]
- practically, sometimes bad performance (overfitting)

our contributions: on Learning with Complementary Labels (LCL)

- analysis: identify weakness of URE framework
- algorithm: propose an improved framework
- experiment: demonstrate stronger performance

#### next: introduction to LCL

[DNS15] Convex formulation for learning from positive and unlabeled data, ICML'15.

[Ish+19] Complementary-Label Learning for Arbitrary Losses and Models, ICML'19.

[Pat+17] Making deep neural networks robust to label noise: A loss correction approach, CVPR'17.

Chou et al.

Motivation behind Learning with Complementary Label

### complementary label $\overline{y}_n$ instead of true $y_n$

True Label









Complementary Label

Not "monkey"



Not "meerkat"



Not "prairie dog"

#### Figure 1 of [Yu+18]

# complementary label: **easier/cheaper** to obtain for some applications

#### Introduction

## Fruit Labeling Task (Image from AICup in 2020)



hard: true label	easy: complementary label	
<ul> <li>orange ?</li> <li>cherry</li> <li>mango ?</li> <li>banana</li> </ul>	<ul> <li>orange</li> <li>mango</li> <li>banana X</li> </ul>	

complementary: less labeling cost/expertise required

Chou et al.

Introduction

### Comparison

### Ordinary (Supervised) Learning

training: 
$$\{(\mathbf{x}_n = \mathbf{x}_n, y_n = \text{mango})\} \rightarrow \text{classifier}$$

#### **Complementary Learning**

training: 
$$\{(\mathbf{x}_n = \mathbf{x}_n, \overline{y}_n = \text{banana})\} \rightarrow \text{classifier}$$

testing goal: **classifier**( 
$$\rightarrow$$
 )  $\rightarrow$  cherry

# ordinary versus complementary: same goal via different training data

Chou et al.

### Learning with Complementary Labels Setup

#### Given

*N* examples (input  $\mathbf{x}_n$ , complementary label  $\overline{y}_n$ )  $\in \mathcal{X} \times \{1, 2, \dots K\}$  in data set  $\mathcal{D}$  such that  $\overline{y}_n \neq y_n$  for some hidden ordinary label  $y_n \in \{1, 2, \dots K\}$ .

#### Goal

a multi-class classifier  $g(\mathbf{x})$  that closely predicts (0/1 error) the ordinary label *y* associated with some **unseen** inputs *x* 

LCL model design: connecting complementary & ordinary

# Unbiased Risk Estimation for LCL

### Ordinary Learning

• empirical risk minimization (ERM) on training data

risk:  $\mathbb{E}_{(\mathbf{x},y)}[\ell(y,g(\mathbf{x}))]$  empirical risk:  $\mathbb{E}_{(\mathbf{x}_n,y_n)\in\mathcal{D}}[\ell(y_n,g(\mathbf{x}_n))]$ 

• loss  $\ell$ : usually **surrogate** of 0/1 error

### LCL [lsh+19]

• rewrite the loss  $\ell$  to  $\overline{\ell}$ , such that

unbiased risk estimator:  $\mathbb{E}_{(\mathbf{x},\overline{y})}[\overline{\ell}(\overline{y},g(\mathbf{x}))] = \mathbb{E}_{(\mathbf{x},y)}[\ell(y,g(\mathbf{x}))]$ 

• LCL by minimizing **URE** 

#### URE: pioneer models for LCL

Chou et al.

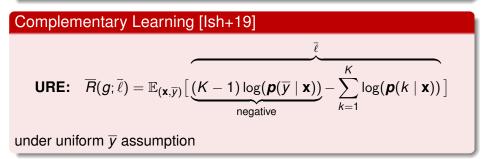
### Example of URE

### Cross Entropy Loss

for  $g(\mathbf{x}) = \operatorname{argmax}_{k \in \{1,2,\dots,K\}} \boldsymbol{p}(k \mid \mathbf{x}),$ 

•  $\ell_{CE}$ : derived by maximum likelihood as surrogate of 0/1

risk: 
$$R(g; \ell_{CE}) = \mathbb{E}_{(\mathbf{x}, y)} \underbrace{(-\log(\mathbf{p}(y \mid \mathbf{x})))}_{\ell_{CE}}$$



ERM with URE:  $\min_{p} \overline{R}$  with  $\mathbb{E}$  taken on  $\mathcal{D}$ 

Chou et al.

Problems of URE

### URE overfits on single label

$$\ell = -\log(\boldsymbol{p}(\boldsymbol{y} \mid \boldsymbol{x}))$$
$$\bar{\ell} = (K-1)\log(\boldsymbol{p}(\overline{\boldsymbol{y}} \mid \boldsymbol{x})) - \sum_{k=1}^{K}\log(\boldsymbol{p}(k \mid \boldsymbol{x}))$$

### ordinary risk and URE very different

- $\ell > 0 \rightarrow$  ordinary risk non-negative
- small p(y
   | x) (often) → possibly very negative l
   empirical URE can be negative: only observing some but not all
   y
- negative empirical URE drags minimization towards overfitting

#### practical remedy: [lsh+19]

NN-URE: constrain emprical URE to be non-negative

how can we avoid negative empirical URE?

Chou et al.

#### Proposed Framework

### **Proposed Framework**

#### Minimize Complementary 0/1

- Recall the goal: We minimize 0-1 loss instead of  $\ell$
- The unbiased estimator of R<sub>01</sub>

$$\overline{\boldsymbol{R}}_{\overline{\boldsymbol{0}1}}: \quad \mathbb{E}_{\overline{\boldsymbol{y}}}[\overline{\ell}_{01}(\overline{\boldsymbol{y}},g(\mathbf{x}))] = \ell_{01}(\boldsymbol{y},g(\mathbf{x}))$$

• We denote  $\overline{\ell}_{01}$  as the complementary 0-1 loss:

$$\overline{\ell}_{01}(\overline{y},g(\mathbf{x})) = \llbracket \overline{y} = g(\mathbf{x}) 
rbracket$$

#### Surrogate Complementary Loss (SCL)

- Surrogate loss to optimize  $\overline{\ell}_{01}$
- Unify previous work as surrogates of  $\overline{\ell}_{01}$  [Yu+18; Kim+19]

<sup>[</sup>Yu+18] Learning with biased complementary labels, ECCV'18.

<sup>[</sup>Kim+19] NInI: Negative learning for noisy labels, ICCV'19.

### Negative Risk Avoided

### Unbiased Risk Estimator (URE)

URE loss  $\overline{\ell}_{CE}$  [Ish+19] from cross-entropy  $\ell_{CE}$ ,

$$\overline{\ell}_{CE}(\overline{y}, g(\mathbf{x})) = \underbrace{(K-1)\log(\mathbf{p}(\overline{y} \mid \mathbf{x}))}_{\text{negative loss term}} - \sum_{j=1}^{K}\log(\mathbf{p}(j \mid \mathbf{x}))$$

can go negative.

### Surrogate Complementary Loss (SCL)

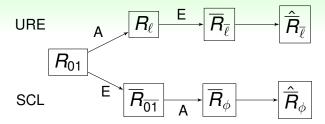
another loss [Kim+19], a surrogate  $\overline{\ell}_{01}$ 

$$\phi_{\mathsf{NL}}(\overline{y}, g(\mathbf{x})) = -\log(1 - \boldsymbol{p}(\overline{y} \mid \mathbf{x})))$$

remains non-negative.

Chou et al.

## Illustrative Difference between URE and SCE



### URE: Ripple effect of errors

- Theoretical motivation [Ish+17]
- Estimation step (E) amplifies approximation error (A) in  $\overline{\ell}$

#### SCL: 'Directly' minimize complementary likelihood

- Non-negative loss  $\phi$
- Practically prevents ripple effect

Chou et al.

### **Classification Accuracy**

### Methods

- Unbiased risk estimator (URE) [Ish+19]
- 2 Non-negative correction methods on URE (NN) [Ish+19]
- Surrogate complementary loss (SCL)

Table: URE and NN are based on  $\overline{\ell}$  rewritten from cross-entropy loss, while SCL is based on exponential loss  $\phi_{\mathsf{EXP}}(\overline{y}, g(\mathbf{x})) = \exp(\mathbf{p}_{\overline{y}})$ .

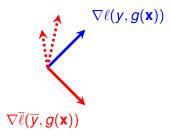
Data set + Model	URE	NN	SCL
MNIST + Linear	0.850	0.818	0.902
MNIST + MLP	0.801	0.867	0.925
CIFAR10 + ResNet	0.109	0.308	0.492
CIFAR10 + DenseNet	0.291	0.338	0.544

#### Gradient Analysis

### **Gradient Analysis**

### Gradient Direction of URE

- Very diverged directions on each  $\overline{y}$  to maintain unbiasedness
- Low correlation to the target  $\ell_{01}$



### Gradient Direction of SCL

- Targets to minimum likelihood
   objective
- High correlation to the target  $\overline{\ell}_{01}$

#### Figure: Illustration of URE

### Gradient Estimation Error

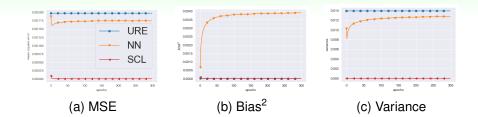
#### **Bias-Variance Decomposition**

$$\mathsf{MSE} = \mathbb{E}[(\boldsymbol{f} - \boldsymbol{c})^2] \\ = \underbrace{\mathbb{E}[(\boldsymbol{f} - \boldsymbol{h})^2]}_{\mathsf{Bias}^2} + \underbrace{\mathbb{E}[(\boldsymbol{h} - \boldsymbol{c})^2]}_{\mathsf{Variance}}$$

### **Gradient Estimation**

- **1** Ordinary gradient  $\mathbf{f} = \nabla \ell(\mathbf{y}, \mathbf{g}(\mathbf{x}))$
- **2** Complementary gradient  $\boldsymbol{c} = \nabla \overline{\ell}(\overline{y}, g(\mathbf{x}))$
- 3 Expected complementary gradient h

### **Bias-Variance Tradeoff**



### Findings

• SCL reduces variance by introducing small bias (towards  $\overline{y}$ )

	Bias	Variance	MSE
URE	0	Big	Big
SCL	Small	Small	Small

### Conclusion

#### Explain Overfitting of URE

- Unbiased method only do well in expectation
- Single fixed complementary label cause overfitting

### Surrogate Complementary Loss (SCL)

- Minimum likelihood approach
- Avoids negative risk problem

#### **Experiment Results**

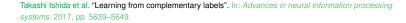
- SCL significantly outperforms other methods
- Introduce small bias for lower gradient variance

### References

Marthinus Du Plessis, Gang Niu, and Masashi Sugiyama. "Convex formulation for learning from positive and unlabeled data". In: International Conference on Machine Learning. 2015, pp. 1386–1394.



Charles Elkan and Keith Noto. "Learning classifiers from only positive and unlabeled data". In: Proceedings of the 14th ACM SIGKDD international conference on Knowledge discovery and data mining. 2008, pp. 213–220.



Takashi Ishida et al. "Complementary-Label Learning for Arbitrary Losses and Models". In: International Conference on Machine Learning. 2019, pp. 2971–2980.

Youngdong Kim et al. "NInl: Negative learning for noisy labels". In: Proceedings of the IEEE International Conference on Computer Vision. 2019, pp. 101–110.

Nagarajan Natarajan et al. "Learning with noisy labels". In: Advances in neural information processing systems. 2013, pp. 1196–1204.

Giorgio Patrini et al. "Making deep neural networks robust to label noise: A loss correction approach". In: Proceedings of the IEEE Conference on Computer Vision and Pattern Recognition. 2017, pp. 1944–1952.

Xiyu Yu et al. "Learning with biased complementary labels". In: Proceedings of the European Conference on Computer Vision (ECCV). 2018, pp. 68–83.